

PTO/SB/08A (10-01)

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(use as many sheets as necessary)

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Co	mplete if Known	
Application Number	09/815,886	
Filing Date	3/22/2001	
First Named Inventor	Krasnov	
Art Unit	1745	
Examiner Name	Unknown	
Attorney Docket Number	Front.4.US	_

U.S. PATENT DOCUMENTS					
Examiner hitials	Cite No. 1 Number - Kind Code² (if known		Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
	us- 5512147 A	04-30-1996	Bates John B, et al.	col. 3, line 33-67	
	us- 5612152 A	03-18-1997	Bates John B	col. 3, line 21-43	
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		FORI	IGN PATENT D	OCUMENTS		
Examin Initials	er Cite No. 1	Foreign Patent Document Country Code ³ -Number ⁴ - Kind Code ⁵ (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	Т6
192	1	WO 02 21627 A	03-14-2002	Front Edge Technology	p4 ln6-30; p5 ln16-27	Х
NO		WO 00 60689 A	10-12-2000	Neudecker, et al.	p2 ln18-24; p5 ln7-25	Х
18		FR-2-403-652-A	-04-13-1979	Anvar	-p4,ln38-p5,ln5; p7,ln20-ln26-	
(A)		JP 59 226472 A	12-19-1984	Hitachi Seisakusho KK	abstract	
KIL.		JP 2001 044073 A	02-16-2001	Sony Corp	abstract	
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Examiner Date Considered Signature

*EXAMINER: Initial II reference considered, whether or not citation is in conformance with MPEP 609. Dray line through citation if not in

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Sheet 2 of 2

Cor	mplete if Known	
Application Number	09/815,886	
Filing Date	3/22/2001	
First Named Inventor	Krasnov	
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Attorney Docket Number	Front.4.US	

Examiner Initials	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	,
		ROH N-S, et al., "Effects of deposition condition on the ionic conductivity and structure of amorphous lithium phosphorus oxynitrate thin film" Scripta Materialia, 12/17/99, pages 43-49, vol. 42, no. 1, Elsevier, New York, NY, US.	,
		BOLSTER M-E, et al. "Investigation of lithium intercalation metal oxides for thermal batteries" Proceedings of the International Power Sources Symposium, Cherry Hill, June 25-28, 1990; 25 June 1990, pages 136-140, vol. SYMP. 34, IEEE, New York, US.	>
		WAGNER A V, et al. "Fabrication and testing of thermoelectric thin film devices" Fifteenth International Conference on Thermoelectrics, Pasadena, CA, USA 26-29 March 1996; 26 March 1996, pages 269-273, IEEE, New York, US.	,
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